

The MAPS Based Pixel Vertex Detector for the STAR Experiment

Vertex 2013 - 22nd International Workshop on Vertex Detectors Lake Starnberg, Germany, 16-20 September 2013

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Outline

STAR Heavy Flavor Tracker Upgrade

- Physics Motivation
- HFT Detector Description
- PXL Detector Requirements
- PXL Design Implementation
- PXL Detector production
 - Production Process
 - Engineering Run Detector
 - Final Detector

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STAR HFT Upgrade Motivation



200 GeV Au-Au collisions @ RHIC



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PXL in STAR Inner Detector Upgrades



PXL Detector Requirements and Design Choices



- $-1 \leq Eta \leq 1$, full Phi coverage (TPC coverage)
- \leq 30 µm DCA pointing resolution required for 750 MeV/c kaon
 - Two or more layers with a separation of > 5 cm
 - Pixel size of \leq 30 µm
 - ▶ Radiation length as low as possible but should be $\leq 0.5\%$ / layer (including support structure). The goal is 0.37% / layer
- ▶ Integration time of < 200 µs
- Sensor efficiency \geq 99% with accidental rate \leq 10⁻⁴
- Survive radiation environment

- Air cooling
- MAPS (Monolithic Active Pixel Sensor) pixel technology
 - Sensor power dissipation ~170 mW/cm²
 - ▶ Sensor integration time <200 µs (L=8×10²⁷)
- Thinned silicon sensors (50 µm thickness)
- Quick extraction and detector replacement (I day)

Design Choices

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PXL Design Implementation





PXL Detector Design



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- 4 ladders / sector
- 5 sectors / half (10 sectors total)
- 2 layers
- Insertion from one side

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Ladder	with 10 MAPS sens	ors (~ 2×2 cm	each)		(~ 200 µm thick)
RDO buffers/ drivers	MAPS				
	Aluminum conductor L	adder Flex Cable		-	
-	•	- 20 cm ———			
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The Ultimate2 Sensor



- Power dissipation ~170 mW/cm² @ 3.3V
- Short integration time 185.6 μs

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- > 2 LVDS data outputs @ 160 MHz
- 4 sub-arrays to help with process variation
- Built-in automated testing routines for sensor testing and characterization

- Standard commercial CMOS technology
- IPHC MIMOSA Series
- Room temperature operation
- Proven thinning to 50 μm



AR HFT



The Hybrid Cable



- Sensor readout and powering
- Minimal radiation length
 - > Production aluminum conductor flex cables are being fabricated in the CERN PCB shop
 - Copper conductor flex cables for the Engineering Run detector

Low mass region calculated X/X_0 for AI conductor = 0.079 % Low mass region calculated X/X_0 for Cu conductor = 0.232 %



Hybrid Copper / Aluminum conductor flex cable design concept

- > 20 differential signal output pairs
- JTAG, 2 temp diodes, CLK, START
- VDD, VDA, GND ~1.8 A / ladder







PXL Detector Powering and Readout Chain





PXL Detector Production





PXL Detector Production - work flow chart 1





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PXL Detector Production – work flow chart 2





PXL Probe Testing: Setup

- Full sensor characterization
- Thinned and diced 50 µm thick sensors (curved)
- Full speed readout (160 MHz)



Vacuum chuck for testing 20 thin sensors (50 μ m) Testing up to 18 sensors per batch Manual alignment



Probe card with readout electronics Analog and digital sensor readout

LabWindows GUI







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PXL Probe Testing: Parameters

- Parameter characterization at different bias V (@ 2.9V, 3V, 3.3V)
 - I/V measurements (analog, digital, clamping V)
 - Optimal potential levels
 - Noise
 - Fast readout mode
 - Accidental hit rate scan
 - Response to LED pulse (@ 3.3V)
- Automated interface to a database
 - Optimal parameters used for final detector configuration



Sensor threshold scan







Sensor positioning

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FR-4 Handler

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Ladder Assembly

Precision vacuum chuck fixtures to position sensors

 Sensors are positioned with butted edges. Acrylic adhesive prevents CTE difference based damage.

Weights taken at all assembly steps to track material and as QA. Hybrid cable with carbon fiber stiffener plate on back in position to glue on sensors.



Cable reference holes for assembly

Assembled ladder







From ladders to sectors... to detector halves





Sector assembly fixture

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Prototype sectors in a detector half

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Sectors

- Ladders are glued on carbon fiber sector tubes in 4 steps
- Pixel positions on sector are measured and related to tooling balls
- After touch probe measurements, sectors are tested electrically for damage from metrology



Sector in the metrology setup

Detector half

- Sectors are mounted in dovetail slots on detector half
- Metrology is done to relate sector tooling balls to each other and to kinematic mounts → Detector half mapped







Engineering Run Detector

Goals:

- Produce and assemble as many working sectors as possible to face the detector-level problems
- > Test full insertion mechanism, parallel powering, trigger, readout
- Test cooling performance

The Prototype Detector

- > 3 full sectors distributed over the 2 detector halves
- Functional sensors
 - A certain inefficiency is accepted in the prototype detector
- Production detector powering and readout chain design and mechanics









Engineering Run Detector Installation

Detector preparation @ STAR Clean Room

- Half detectors integrated in the insertion mechanics w/ full RDO and Power chains
- Detector functionalities tested
- Insertion and full chain connection
 - Effectively completed within an 8-hours shift

Left side insertion



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Integration with insertion mechanics

Right side insertion







Engineering Run Detector inserted





Successfully inserted, cabled, powered \rightarrow fully working







Engineering Run operations

- Insertion on May, 8 2013 (during 16h stop of beam activities)
- > PXL Engineering Run schedule
 - I. Commissioning (First 10 days, mainly when no beam):
 - Firmware completion and integration
 - Sensor threshold tuning and initialization procedure implementation
 - Integration with the STAR Slow Control, Trigger, DAQ, Cooling infrastructure
 - 2. Low Luminosity Runs (Second part of the Run)
 - 2% of full luminosity thanks to beam displacement to reduce pile up and irradiation
 - Data acquisition with STAR detector to collect data for tracking performance analysis
 - 3. High Luminosity Runs (Last 3 days of the Run)
 - Nominal 400kHz collision rate, pre-scaled trigger rate to minimize PXL data
 - □ SEU test
 - □ High irradiation

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Collected Data & Events

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- ~ 600 GB low multiplicity PXL data (~10 million events) + ~ 180 GB of high multiplicity
- ▶ Detector now back @ LBL for post-run examination
 - Current draw increase and sensor behavior under study



Preliminary results from Engineering Run



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Hit display for PXL Engineering Run detector.

TPCtrack-PXLhit residuals

- First tracking results show good matching of TPC tracks to hits on PXL sensors
- Residuals compatible with TPCtrack resolutions on the sensors (~1-2 mm)
- 3 mm beam shift reflects the PXL&TPC relative position



Lessons learned

The fabrication of complete sectors allowed discovering and correcting the production problems

- I. Single sensor flaws appeared on ladder
 - Limits on functional parameters, e.g. current draw, added to rejection criteria for sensors
 - Specific fast readout mode tests added
- 2. Cracks in sensors during vacuum bag cycling and sector assembly
 - Sensor and tool cleaning improved
 - Sector assembly fixtures machined to safely accommodate the silicon
- 3. Mismatch in bonding wire assignment and pad-to-trace misalignment
 - Bonding diagram optimized for the new sensor layout
 - Sensor dimension stability with DRIE dicing



Memory block power circuit internally shorted to ground: High current draw in probe testing Hot region from IR inspection



Hole/crack caused by high pressure on dust

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Lessons learned - 2



Shorts between power and gnd, or LVDS outputs 4.

- Adhesive layer extended in both dimensions to increase the portion coming out from underneath the sensors
- Insulating solder mask added to low mass cables



Flawed ladder dissection: searching for shorts



Inner layer design



- Mechanical interference in the driver boards 5 on the existing design.
 - The sector tube and inner ladder driver board have been redesigned to give a reasonable clearance fit
 - Inner layer design modification: ~ 2.7 cm inner radius

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Lessons learned - 3

- PXL Engineering Run assembly crucial to deal with a large number of unexpected issues
- Assembly procedure refined and effective tools for troubleshooting ladders developed on the basis of this experience

ER ladder quality assessment (03/20/2013)	#	%
Fully operating ladders	15	55.6
Lower quality operating ladders (>8 operating chips)	4	14.8
Recoverable not operating ladders (need fix or workaround)	4	14.8
Dead ladders (not recoverable)	4	14.8
Total	27	100.0

▶ Goal for the final PXL detector: ladder construction yield close to ~100%







Final PXL Detector Production Status

36 ladders assembled

- Fully functional sensors
- Cu low-mass cable, new design including solder mask on both sides
 - Al low-mass cable delivery delayed to mid September, expected for the inner layer
- > 96% assembly yield over the tested ladders
 - > 24 Ladders completed, ready to be assembled on sectors
- MTB Electronic Boards being redesigned
- Production Firmware major upgrade
- Detector control software optimized

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Summary and Outlook

Engineering Run PXL Detector successfully assembled and installed in STAR

- Many unexpected production problems discovered and corrected
- Insertion and readout chain fully validated
- Preliminary results from collected data show good matching with TPC tracks
- The Production PXL Detector is now coming together:
 - Primary detector to be installed by December 2013
 - **Spare detector** to be delivered to BNL by beginning 2014
 - Additional single **spare ladders** to be assembled by Spring 2014
- First Production Data expected for Jan/Feb 2014







Thank you for your attention!







Spare Material







Design Specifications

Pointing resolution	(I2 ⊕ I9 GeV/p·c) μm		
Layers	Layer I at 2.7 cm radius		
	Layer 2 at 8 cm radius		
Pixel size	20.7 μm X 20.7 μm		
Hit resolution	6 μm		
Position stability	6 μm rms (20 μm envelope)		
Radiation length per layer	$X/X_0 = 0.37\%$		
Total sensitive area	0.15 m ²		
Number of pixels	356 M		
Frame integration time (affects pileup)	185.6 μs		
Radiation environment	20 to 90 kRad / year 2*10 ¹¹ to 10 ¹² IMeV n eq/cm ²		
Rapid detector replacement	< I day		



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Radiation Length of active area

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PXL detector – insertion mechanics





- Unusual mechanical approach.
- Cantilevered and insertable (I day)
- Pre-surveyed and mechanically stable to a level that preserves the survey.
- Detector inserts and initiates a clamshell closing around beam pipe, and is locked into position on kinematic mounts.





PXL insertion mechanics





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Interaction point view of the PXL insertion rails and kinematic mount points

Carbon fiber rails

Kinematic mounts

